Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/787,070	KAHNG ET AL.
Examiner	Art Unit
 Sun J. Lin	2825

	SEARCHED				
Class	Subclass	Date	Examiner		
716	21	10/26/2005	JSL 		
716	19	10/26/2005	JSL		
			<i>-</i>		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST [USPAT;US- PGPUB;EPO;JPO;DERWENT;IBM_T DB]	10/26/2005	JSL
EAST [USPAT;US- PGPUB;EPO;JPO;DERWENT;IBM_T DB]	10/27/2005	JSL
IEEE	10/27/2005	JSL
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